Search Notes				

Application/Control No.	Applicant(s)/Patent un Reexamination	nder
10/743,386	MATSUKAWA ET AL	
Examiner	Art Unit	,
Lois Zheng	1742	

SEARCHED			
Class	Subclass	Date	Examiner
148	243	11/17/2006	LLZ
148	274	11/17/2006	LLZ
106	14.11	11/17/2006	LLZ
106	14.15	11/17/2006	LLZ
106	14.44	11/17/2006	LLZ

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
1			

SEARCH (INCLUDING SEAR		Y)
	DATE	EXMR
inventorship search	11/17/2006	LLZ
Updated EAST search	11/17/2006	LLZ
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